

Abstract Submitted
for the MAR07 Meeting of
The American Physical Society

Determination of the cross-sectional area of the indenter in nano indentation tests¹ WEIDIAN SHEN, JEREMY MCMINIS, RENE CROMBEZ, EVA MONTALVO, Surface Science and Nano-Tribology Laboratory, Department of Physics and Astronomy, Eastern Michigan University — To measure the hardness and elastic modulus of a composite system in the nano scale the precise determination of the cross-section area of the indenter tip at different heights is a key. A method of using scanning probing microscopy to image the tip, and then using its analysis software, Histogram program and Bearing curve, combined with the information of the area of each pixel, to determine the cross section area at different heights is introduced in this presentation. Compared with other techniques, it is simple, straightforward, and readily provides a precise relationship between the cross-sectional area and the height.

¹Support of this work by Office of Naval Research (ONR) is greatly appreciated

Weidian Shen
Surface Science and Nano-Tribology Laboratory
Department of Physics and Astronomy, Eastern Michigan University

Date submitted: 25 Nov 2006

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